

T-1^{3/4} 670 nm High Radiant Intensity Emitter

Technical Data

HEMT-3300

Features

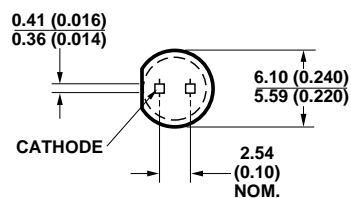
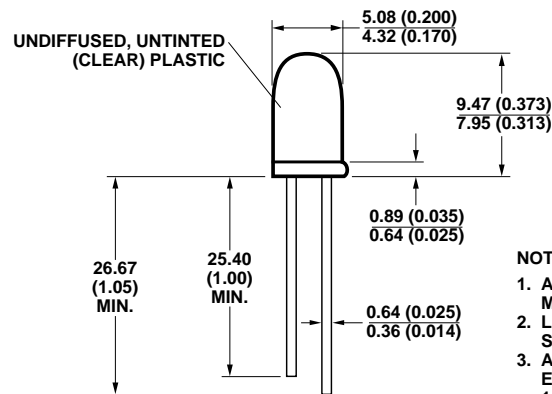
- **High Efficiency**
- **Nonsaturating Output**
- **Narrow Beam Angle**
- **Visible Flux Aids Alignment**
- **Bandwidth: DC to 3 MHz**
- **IC Compatible/Low Current Requirement**

Description

The HEMT-3300 is a visible, near-IR, source using a GaAsP on GaP LED chip optimized for maximum quantum efficiency at 670 nm. The emitter's beam is sufficiently narrow to minimize stray flux problems, yet broad enough to simplify optical

alignment. This product is suitable for use in consumer and industrial applications such as optical transducers and encoders, smoke detectors, assembly line monitors, small parts counters, paper tape readers, and fiber optic drivers.

Package Dimensions



Absolute Maximum Ratings at $T_A = 25^\circ\text{C}$

Power Dissipation	120 mW (derate linearly from 50°C at $1.6\text{ mW}/^\circ\text{C}$)
Average Forward Current	30 mA (derate linearly from 50°C at $0.4\text{ mA}/^\circ\text{C}$)
Peak Forward Current	See Figure 5
Operating and Storage Temperature Range	-55°C to $+100^\circ\text{C}$
Lead Soldering Temperature	260°C for 5 seconds (1.6 mm [0.063 in.] from body)

Electrical/Optical Characteristics at $T_A = 25^\circ\text{C}$

Symbol	Description	Min.	Typ.	Max.	Units	Test Conditions	Fig.
I_e	Axial Radiant Intensity	200	500		$\mu\text{W}/\text{sr}$	$I_F = 10\text{ mA}$	3, 4
K_e	Temperature Coefficient of Intensity		-0.009		$^\circ\text{C}^{-1}$	$I_F = 10\text{ mA}$, Note 1	
η_v	Luminous Efficacy		22		lm/W	Note 2	
$2\theta_{1/2}$	Half Intensity Total Angle		22		deg.	Note 3, $I_F = 10\text{ mA}$	6
λ_{PEAK}	Peak Wavelength		670		nm	Measured at Peak	1
$\Delta\lambda_{\text{PEAK}}/\Delta T$	Spectral Shift Temperature Coefficient		0.089		$\text{nm}/^\circ\text{C}$	Measured at Peak, Note 4	
t_r	Output Rise Time (10% to 90%)		120		ns	$I_{\text{PEAK}} = 10\text{ mA}$	
t_f	Output Fall Time (90% to 10%)		50		ns	$I_{\text{PEAK}} = 10\text{ mA}$	
C_O	Capacitance		15		pF	$V_F = 0$; $f = 1\text{ MHz}$	
BV_R	Reverse Breakdown Voltage	5.0			V	$I_R = 100\ \mu\text{A}$	
V_F	Forward Voltage		1.9	2.5	V	$I_F = 10\text{ mA}$	2
$\Delta V_F/\Delta T$	Temperature Coefficient of V_F		-2.2		$\text{mV}/^\circ\text{C}$	$I_F = 100\ \mu\text{A}$	
$R\theta_{\text{J-PIN}}$	Thermal Resistance		260		$^\circ\text{C}/\text{W}$	LED Junction to Cathode Lead.	

Notes:

- $I_e(T) = I_e(25^\circ\text{C})\exp[K_e(T - 25^\circ\text{C})]$.
- $I_v = \eta_v I_e$ where I_v is in candela, I_e in watts/steradian and η_v in lumen/watt.
- $\theta_{1/2}$ is the off-axis angle at which the radiant intensity is half the axial intensity.
- $\lambda_{\text{PEAK}}(T) = \lambda_{\text{PEAK}}(25^\circ\text{C}) + (\Delta\lambda_{\text{PEAK}}/\Delta T)(T - 25^\circ\text{C})$.

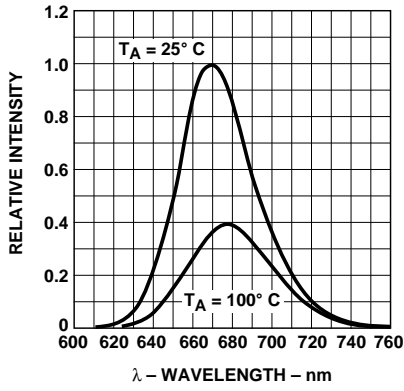


Figure 1. Relative Intensity vs. Wavelength.

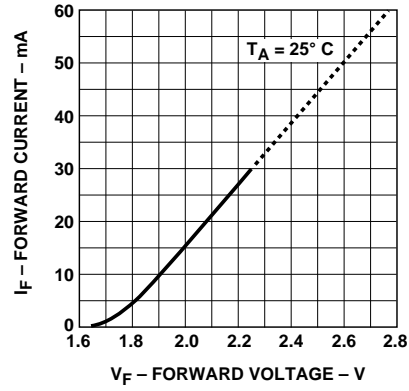


Figure 2. Forward Current vs. Forward Voltage.

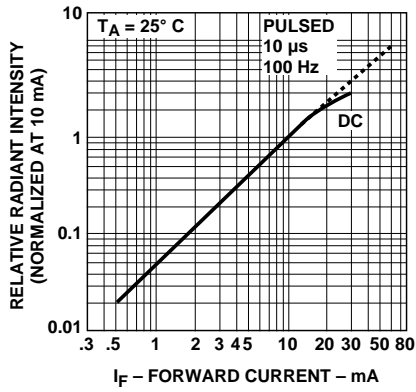


Figure 3. Relative Radiant Intensity vs. Forward Current.

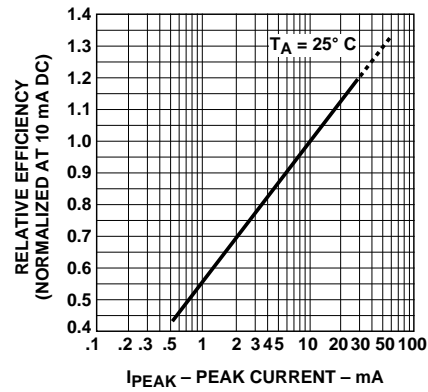


Figure 4. Relative Efficiency (Radiant Intensity per Unit Current) vs. Peak Current.

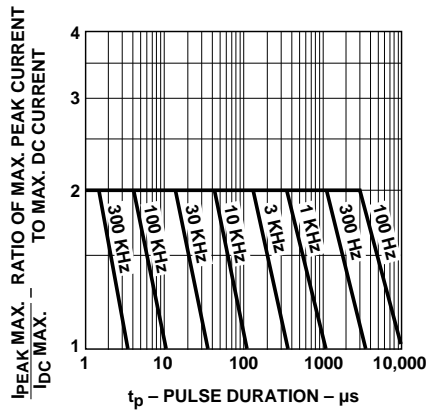


Figure 5. Maximum Tolerable Peak Current vs. Pulse Duration. ($I_{DC\ MAX}$ as per MAX Ratings)

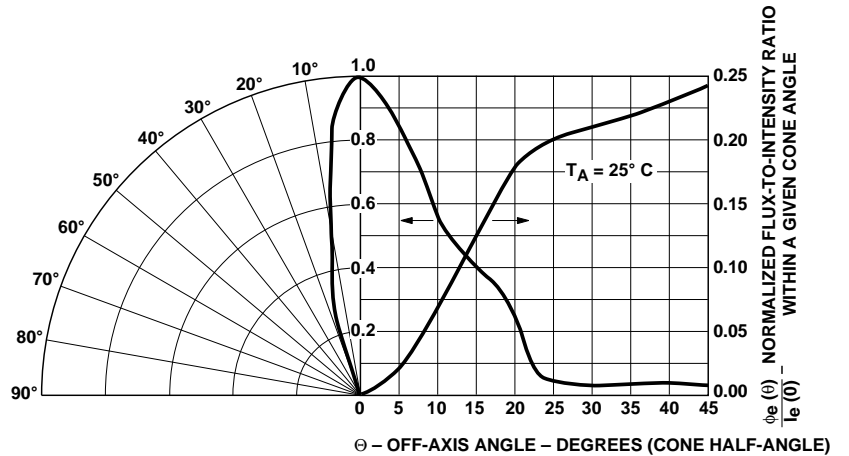
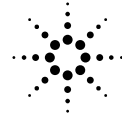


Figure 6. Far-Field Radiation Pattern.



Agilent Technologies
Innovating the HP Way

www.semiconductor.agilent.com

Data subject to change.

Copyright © 1999 Agilent Technologies, Inc.

Obsoletes 5952-8498 (8/76)

5964-6427E (11/99)